

N-CHANNEL ENHANCEMENT MOS FET

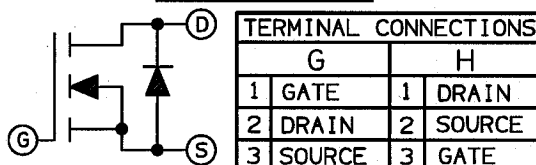
400V, 25A, 0.21Ω

SDF360 JEA
SDF360 JEB
SDF360 JEC
SDF360 JED

FEATURES

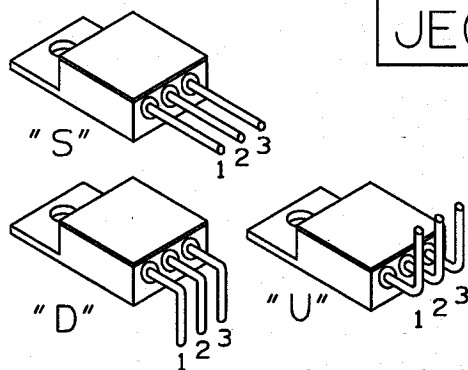
- RUGGED PACKAGE
- HI-REL CONSTRUCTION
- CERAMIC EYELETS
- LEAD BENDING OPTIONS
- COPPER CORED 52 ALLOY PINS
- LOW IR LOSSES
- LOW THERMAL RESISTANCE
- OPTIONAL MIL-S-19500 SCREENING

SCHEMATIC



STANDARD BEND CONFIGURATIONS

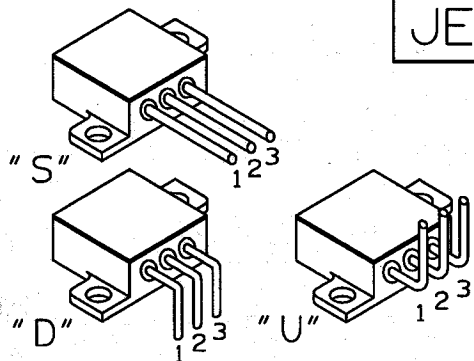
JEA
JEC



(CUSTOM BEND OPTIONS AVAILABLE)

STANDARD BEND CONFIGURATIONS

JEB
JED



(CUSTOM BEND OPTIONS AVAILABLE)

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL		UNITS
Drain-source Volt.(1)	VDSS	400	Vdc
Drain-Gate Voltage (RGS=1.0MΩ) (1)	VDGR	400	Vdc
Gate-Source Voltage Continuous	VGS	±20	Vdc
Drain Current Continuous (Tc = 25°C)	ID	25	Adc
Drain Current Pulsed(3)	IDM	100	A
Total Power Dissipation	PD	250	W
Power Dissipation Derating > 25°C		2.0	W/°C
Operating & Storage Temp.	TJ/Tsig	-55 TO +150	°C
Thermal Resistance	RthJc	0.5	°C/W
Max.Lead temperature	TL	300	°C

ELECTRICAL CHARACTERISTICS Tc = 25°C (UNLESS OTHERWISE SPECIFIED)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Drain-source Breakdown Volt.	V(BR)DSS	VGS=0V ID=250 μA	400	-	-	V
Gate Threshold Voltage	VGS(TH)	VDS=VGS ID=250 μA	2.0	-	4.0	V
Gate Source Leakage	IGSS	VGS=±20 V	-	-	100	nA
Zero Gate Voltage Drain Current	IDSS	VDS=MAX.RATING VGS=0 VDS=0.8 MAX.RATING VGS=0 TJ=125°C	-	-	250 1000	μA
Static Drain-Source On-State Resistance(1)	RDS(ON)	VGS=10 V ID=14A	-	-	.21	Ω
Forward Trans-Conductance (2)	gfs	VDS ≥ 50 V IDS=14A	14	-	-	S(U)
Input Capacitance	CISS		-	4000	-	pF
Output Capacitance	COSS	VGS=0V VDS=25 V f=1.0 MHz	-	550	-	pF
Reverse Transfer Capacitance	CRSS		-	97	-	pF
Turn-On Delay	td(on)	VDD=200V RG=4.3n ID=25A RD=7.5n	-	-	33	ns
Rise Time	tr	(MOSFET switching times are essentially independent of operating temp.)	-	-	140	ns
Turn-Off Delay	td(off)		-	-	120	ns
Fall Time	tf		-	-	99	ns
Total Gate Charge (Gate-Source Plus Gate-Drain)	Qg	VGS=10V, ID=25A VDS=0.8 MAX.RATING (Gate charge is essentially independent of the operating temperature)	-	-	170	nC
Gate-Source Charge	Qgs		-	-	28	nC
Gate-Drain ("Miller") Charge	Qgd		-	-	90	nC

SOURCE-DRAIN DIODE RATINGS & CHARACT. Tc = 25°C (UNLESS OTHERWISE SPECIFIED)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Continuous Source Current (Body Diode)	IS	Modified MOSFET symbol showing the integral reverse P-N junction rectifier (See schematic)	-	-	25	A
Pulse Source Current (Body Diode) (1)	ISM		-	-	100	A
Diode Forward Voltage (2)	VSD	IF=25A VGS=0V Tc=+25°C	-	-	1.8	V
Reverse Recovery Time	trr	Tc=+25° C	-	-	1000	ns
Reverse Recovery Charge	Qrr	IF=25A di/dt=100A/μS	-	7.1	-	μC

- (1) TJ = 25°C to 150°C.
(2) Pulse test: Pulse Width < 300μS, Duty Cycle < 2%.
(3) Repetitive Rating: Pulse Width limited By Max. Junction Temperature.